

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/089,067	TAKAYA ET AL.	
Examiner	Art Unit	
longthon Johnson	1725	

	SEARCHED				
Class	Subclass	Date	Examiner		
update Sear	d	.//			
sear	h	2/14/05	De		
	:				

INT	INTERFERENCE SEARCHED				
Class	Subclass	Dat	te	Exar	miner
< (1)	10 Q		1	,	7
3000		2/14	4/05	9	R)
W					L
alre	ne	Ų			/

SEARCH N (INCLUDING SEARC		()
	DATE	EXMR
PALM inventor hame search	2/14/05	20
sequen		
		.
		